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Dual N-Channel PowerTrench[®] MOSFET N-Channel: 30 V, 30 A, 7.5 m Ω N-Channel: 30 V, 40 A, 2.8 m Ω

Features

Q1: N-Channel

- Max $r_{DS(on)}$ = 7.5 m Ω at V_{GS} = 10 V, I_D = 12 A
- Max $r_{DS(on)}$ = 12 m Ω at V_{GS} = 4.5 V, I_D = 10 A

Q2: N-Channel

- Max $r_{DS(on)}$ = 2.8 m Ω at V_{GS} = 10 V, I_D = 20 A
- Max $r_{DS(on)}$ = 3.3 m Ω at V_{GS} = 4.5 V, I_D = 18 A
- RoHS Compliant

General Description

This device includes two specialized N-Channel MOSFETs in a dual MLP package. The switch node has been internally connected to enable easy placement and routing of synchronous buck converters. The control MOSFET (Q1) and synchronous SyncFETTM (Q2) have been designed to provide optimal power efficiency.

Applications

- Computing
- Communications
- General Purpose Point of Load
- Notebook V_{CORE}



MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted

Symbol	Parameter		Q1	Q2	Units
V _{DS}	Drain to Source Voltage		30	30	V
V _{GS}	Gate to Source Voltage	(Note 3)	±20	±20	V
	Drain Current -Continuous	T _C = 25 °C	30	40	
I _D	-Continuous	T _A = 25 °C	12 ^{1a}	22 ^{1b}	Α
	-Pulsed		40	60	Ī
D	Power Dissipation for Single Operation	T _A = 25 °C	2.2 ^{1a}	2.5 ^{1b}	14/
۲D		T _A = 25 °C	1.0 ^{1c}	1.0 ^{1d}	vv
T _J , T _{STG}	Operating and Storage Junction Temperature Range		-55 to	+150	°C

Thermal Characteristics

R_{\thetaJA}	Thermal Resistance, Junction to Ambient	57 ^{1a}	50 ^{1b}	
R_{\thetaJA}	Thermal Resistance, Junction to Ambient	125 ^{1c}	120 ^{1d}	°C/W
$R_{\theta JC}$	Thermal Resistance, Junction to Case	3.5	2	

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMS7600AS	FDMS7600AS	Power 56	13 "	12 mm	3000 units

Symbol	Parameter	Test Conditions	Туре	Min	Тур	Max	Units
Off Chara	octeristics						
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \ \mu A, \ V_{GS} = 0 \ V$ $I_D = 1 \ m A, \ V_{GS} = 0 \ V$	Q1 Q2	30 30			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A, referenced to 25 °C $I_D = 1 \ m$ A, referenced to 25 °C	Q1 Q2		15 18		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 24 V, V_{GS} = 0 V$	Q1 Q2			1 500	μA μA
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = 20 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$	Q1 Q2			100 100	nA nA

$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \ \mu A$ $V_{GS} = V_{DS}, I_D = 1 \ m A$	Q1 Q2	1 1	1.8 1.5	3 3	V
$\frac{\Delta V_{GS(th)}}{\Delta T}$	Gate to Source Threshold Voltage	$I_D = 250 \ \mu$ A, referenced to 25 °C	Q1		-6 -5		mV/°C
		$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 12 \text{ A}$	62		6.0	7.5	
		$V_{GS} = 4.5 \text{ V}, I_D = 10 \text{ A}$	Q1		8.5	12	
r _{DS(on)}	Drain to Source On Resistance	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 12 \text{ A}, \text{ I}_{J} = 125 \text{ °C}$			8.3	12 2.8	mΩ
		$V_{GS} = 4.5 \text{ V}, I_D = 20 \text{ A}$	Q2		2.6	3.3	
		V_{GS} = 10 V, I_D = 20 A , T_J = 125 °C			2.6	3.8	
9 _{ES}	Forward Transconductance	$V_{DS} = 5 V, I_D = 12 A$	Q1		63		S
		$v_{DS} = 5 V, I_D = 20 A$	Q2		190		

Dynamic Characteristics

C _{iss}	Input Capacitance	Q1: V _{DS} = 15 V, V _{GS} = 0 V, f = 1 MHZ	Q1 Q2	1315 5265	1750 7005	pF
C _{oss}	Output Capacitance	Q2:	Q1 Q2	445 2150	600 2860	pF
C _{rss}	Reverse Transfer Capacitance	V _{DS} = 15 V, V _{GS} = 0 V, f = 1 MHZ	Q1 Q2	45 200	70 300	pF
R _g	Gate Resistance		Q1 Q2	0.9 0.3		Ω

Switching Characteristics

t _{d(on)}	Turn-On Delay Time	Q1:		Q1 Q2	8.6 18	18 32	ns
t _r	Rise Time	V _{DD} = 15 V, I _D = 12 V _{GS} = 10 V, R _{GEN}	2 A, = 6 Ω	Q1 Q2	2.5 7.6	10 16	ns
t _{d(off)}	Turn-Off Delay Time	Q2:		Q1 Q2	20 45	32 72	ns
t _f	Fall Time	$V_{DD} = 15$ V, $I_D = 20$ $V_{GS} = 10$ V, R_{GEN}	= 6 Ω	Q1 Q2	2.3 5.2	10 10	ns
Qg	Total Gate Charge	$V_{GS} = 0$ V to 10 V	Q1	Q1 Q2	20 81	28 113	nC
Qg	Total Gate Charge	$V_{GS} = 0$ V to 4.5 V	V _{DD} = 15 V, I _D = 12 A	Q1 Q2	9.3 37	13 52	nC
Q _{gs}	Gate to Source Gate Charge		Q2 Vpp = 15 V	Q1 Q2	4.3 13		nC
Q _{gd}	Gate to Drain "Miller" Charge		$I_{\rm D} = 20 {\rm A}$	Q1 Q2	2.2 9.6		nC

Electrica	al Characteristics T _J = 25 °C ur	less otherwise noted					
Symbol	Parameter	Test Conditions	Туре	Min	Тур	Max	Units
Drain-Sou	rce Diode Characteristics						
V _{SD}	Source to Drain Diode Forward Voltage		Q1 Q2		0.8 0.7	1.2 1.2	V
t _{rr}	Reverse Recovery Time	Q1 I _F = 12 A, di/dt = 100 A/μs	Q1 Q2		27 47	43 75	ns
Q _{rr}	Reverse Recovery Charge	Q2 Ι _F = 20 A, di/dt = 300 A/μs	Q1 Q2		10 80	18 128	nC

Notes:

1: R_{0JA} is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{0JC} is guaranteed by design while R_{0CA} is determined by the user's board design.



c. 125 °C/W when mounted on a minimum pad of 2 oz copper

a. 57 °C/W when mounted on a 1 in² pad of 2 oz copper



80000

d. 120 °C/W when mounted on a minimum pad of 2 oz copper

b. 50 °C/W when mounted on a 1 in² pad of 2 oz copper



2: Pulse Test: Pulse Width < 300 μ s, Duty cycle < 2.0%.

3: As an N-ch device, the negative Vgs rating is for low duty cycle pulse ocurrence only. No continuous rating is implied.





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FDMS7600AS Dual N-Channel PowerTrench[®] MOSFET

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Typical Characteristics (continued)

SyncFET[™] Schottky body diode Characteristics

Fairchild's SyncFETTM process embeds a Schottky diode in parallel with PowerTrench[®] MOSFET. This diode exhibits similar characteristics to a discrete external Schottky diode in parallel with a MOSFET. Figure 25 shows the reverse recovery characteristic of the FDMS7600AS.

Figure 25. FDMS7600AS SyncFETTM Body Diode Reverse Recovery Characteristic

Schottky barrier diodes exhibit significant leakage at high temperature and high reverse voltage. This will increase the power in the device.



Figure 26. SyncFET[™] Body Diode Reverse Leakage vs. Drain-Source Voltage



- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 2009.
- D. LAND PATTERN RECOMMENDATION IS EXISTING INDUSTRY LAND PATTERN.
- E. DRAWING FILENAME: MKT-MLP08Prev2.



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